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# Representing Function-Technology Platform based on the Unified Modeling Language

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## Abstract:

Product platforms are used in many industries to allow a variety of products to be offered to the market while leveraging commonality in components. The reported methodologies to design product platforms assume mature and stable design and manufacturing technologies. Consequently, product platforms are not applicable in the semiconductor equipment manufacturing industries, where the technologies keep evolving and cannot be frozen in the product development process. In response to the application limitations of traditional platforms, a concept of function-technology (FT) platform is put forward to assist the semiconductor equipment manufacturers to efficiently design product families by reusing, in a structured way, functions and technologies. To shed light on the diverse constituent elements and the complex relationships inherent in an FT platform, this study focuses on its structural representation. A formalism of FT platform representation is developed based on the Unified Modeling Language (UML). It consists of a generic functional structure, a generic technology structure and the mapping relationships in between. An application case in a well-known semiconductor equipment manufacturer is also reported to present the structure of an FT platform and its representation based on the UML.

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4 Keywords: Function-technology platform, Unified modeling language, Variant derivation.  
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## 8 **1. INTRODUCTION**

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11 Product platforms have become a principal fundament and a prerequisite for profitable product  
12 development in many industries nowadays (Holmquist, 2004; Sawhney, 1998). The advantages of  
13 developing a number of related products (the so called a product family) based on a common  
14 platform include speeding up product development process, tailoring products to the need of  
15 different market segments and customers, reducing development costs, improving design quality,  
16 etc. (Skold and Karlsson, 2007). Competitive firms are increasingly requiring to reuse their assets  
17 across products because of the growing customization demanded in the market. This reuse is,  
18 however, often limited to physical components without reuse of other kinds of product information.  
19 Especially science based firms, that develop complex products and systems, require the reuse of  
20 product information that captures the scientific knowledge of products.  
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38 The definition of platforms reported in previous studies is effected by the type of product  
39 information that constitutes the platform. In accordance with the authors' expertise and focus,  
40 product platforms have been diversely conceptualized in the literature, ranging from being general  
41 and abstract (McGrath, 1995; Robertson and Ulrich, 1998) to being industry and product specific  
42 (Ericsson and Erixon, 1999; Sanderson and Uzumeri, 1995). Among the many definitions and  
43 descriptions, two common understandings of product platforms can be generalized. In one  
44 perspective, a product platform is viewed as a physical one, consisting of a set of well-structured  
45 tangible elements, such as parts and assemblies, which are common to all variants of the product  
46 family to be developed (Ericsson and Erixon, 1999; Muffatto and Roveda, 2002; Wilhelm, 1997). In  
47 contrast, the other perspective treats a platform as an abstract one formed by a set of intangible  
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4 elements, such as common structures, knowledge about functions and core technologies; with these  
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6 common intangible elements, a product family can be developed (Halman et al., 2003; McGrath,  
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8 1995; Meyer and Lehnerd, 1997; Robertson and Ulrich 1998; Skold and Karlsson, 2007). In these  
9  
10 platform perspectives, however, a formal representation of platforms is lacking. Building on  
11  
12 knowledge on problems with physical platforms (Alblas and Wortmann, 2009; 2010), the present  
13  
14 research aims to further our understanding of the formal structure of platform. In particular, this  
15  
16 research will more precisely examine the functional and technical elements that constitute the  
17  
18 platforms together with the link between these elements. This new formalization of platforms is  
19  
20 required because an increasing number of industries are highly complex and science-based and thus  
21  
22 require to configure product design variants that can be developed further for specific customers.  
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31 Since early 90's, successful platform applications have been increasingly reported in the  
32  
33 literature. However, most of these applications consider products in engineering-based industries,  
34  
35 such as automobiles, airplanes, home appliances, personal computers, bicycles, etc. (e.g. Wilhelm,  
36  
37 1997, Sanderson and Uzumeri, 1997; Feitzinger and Lee, 1997; Whitney, 1993). Moreover, in most  
38  
39 of these applications, the platforms are physical platforms, including common components, modules  
40  
41 and their interfaces. For example, a platform developed by Volkswagen consists of a floor group,  
42  
43 drive system, and running gear, along with the unseen part of the cockpit (Wilhelm, 1997). Based  
44  
45 on this platform, Volkswagen has developed several models within different brands, such as  
46  
47 Volkswagen, Audi, Seat, and Skoda. In comparison, platform applications involving products in  
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49 science-based industries have not been found (Alblas and Wortmann, 2009; 2010).  
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58 Unlike engineering-based industries, science-based industries are characterized by rapid  
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60 innovation speed, short time lags between scientific discoveries and their industrial implementations,  
complex and capital-intensive products (Chuma, 2006). One typical example is the semiconductor

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4 equipment manufacturing industries. In these types of firms, they both develop concepts that are on  
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6 the fences what is scientifically known and available and implement them in commercial products.  
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9 For example, to increase the accuracy of position measurement of a silicon wafer, ASML develops a  
10  
11 new breakthrough mathematical algorithm. This fundamentally differs from firms that develop  
12  
13 products based on known solution principles.  
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16  
17 In these industries, on one hand, the development of new products highly depends on advanced  
18  
19 technologies; on the other hand, these technologies keep evolving during product design and  
20  
21 production. Consequently, some technologies cannot be frozen in product development process  
22  
23 (Chuma, 2006). This not only impacts the mapping from the technologies to the physical  
24  
25 components, but also prohibits the application of physical product platforms, which assume mature  
26  
27 and stable technologies (Alblas and Wortmann, 2009; 2010). In addition, the extreme product  
28  
29 complexity together with the frequent technology innovations during the life cycle of a product  
30  
31 family impede defining stable physical modules that function independently. Consequently, reusing  
32  
33 components/modules cannot be easily achieved. Nevertheless, with well-organized mechanisms,  
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35 efficient reuse of functions and technologies is still possible.  
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44 Same as in other industries, in the semiconductor equipment manufacturing industries, product  
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46 life cycles tend to be shorter; customers increasingly demand higher variety of options; and global  
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48 competition becomes more intense (Chuma, 2006). To survive, semiconductor equipment  
49  
50 manufacturers have to be able to quickly deliver customized products at low costs. In view of the  
51  
52 above application limitations of product platforms, Alblas and Wortmann (2010) put forward a  
53  
54 concept of function-technology (FT) platform, in attempting to assist structured reuse of intangible  
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56 design elements (i.e., functions and technologies) in the semiconductor equipment manufacturing  
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58 industries. An FT platform consists of the common functions associated with a product family and  
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4 the technologies to deliver these functions. In addition, it also captures the interconnections between  
5  
6 functions and technologies. [Abblas and Wortmann \(2010\)](#) have also reported the preliminary results  
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8 of developing FT platforms, including 1) increased reuse of functions and technologies, 2) reduced  
9  
10 development costs and time, and 3) improved capacity allocation.  
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13  
14 While the notion of FT platforms is proposed and its contribution to product family  
15  
16 development is empirically studied in the authors' early work ([Abblas and Wortmann, 2010](#)), the  
17  
18 other issues pertaining to an FT platform, such as rigorous formulation, structural representation,  
19  
20 design and development, etc. are left untouched. The previous work showed some ambiguity in the  
21  
22 definition of platform elements which increased the complexity of managing versions and variants  
23  
24 of these elements and the related products in a family. In this study, in attempting to facilitate  
25  
26 solution development of these issues, we base on this work and use the ASML case to go a step  
27  
28 further to analyze an FT platform from the structural aspect. Thus, our focus is on the structural  
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30 representation of an FT platform in terms of the constitute elements and their relationships. This  
31  
32 structural representation can be used by science-based firms to structure the versions and variants of  
33  
34 functionally and technically defined products within a family. With the findings in terms of essential  
35  
36 elements and their relationships involved in an FT platform, we believe this study would facilitate  
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38 product development planning and structuring decisions and, consequently, influence the  
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40 development of subsequent configuration management tools.  
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52 The rest of this paper is organized as follows: In Section 2, the requirements of representation  
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54 tools are analyzed in accordance with the concept implications of an FT platform; and the unified  
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56 modeling language (UML) is identified as the appropriate tool. An application case is introduced in  
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58 Section 3 with focus on product information, such as the products themselves, the associated  
59  
60 functions and technologies. Sections 4 and 5 detail the UML-based representation of the functional





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4 overall logical organization acts as a generic umbrella, under which specific functions and the  
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6 corresponding technologies can be determined to fulfill customer requirements for specific products  
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8 in a family. In this regard, an FT platform includes all the functions associated with a product family,  
9  
10 the possible technologies that can deliver the functions, and the interconnections in between. With  
11  
12 such a conceptual structure, the derivation of appropriate technologies in accordance with specific  
13  
14 functions of customized products can be achieved. Thus, from the architecture perspective, an FT  
15  
16 platform involves two aspects: 1) a common function-technology (FT) structure within which  
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18 variations in functions and technologies for diverse products belonging to a family can be  
19  
20 differentiated; and 2) the derivation of specific technologies (or technology variants) in relation to  
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22 the corresponding functions from the common FT structure. We first elaborate such concept  
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24 implications of an FT platform as follows.  
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### 33 **2.1 Concept implications of an FT platform**

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36 *The common FT structure:* The common FT structure refers to the generic FT structure  
37  
38 organizing all intangible functional and technology elements in the functional and technology  
39  
40 domains, respectively, that may occur in the targeted product family. It is formed by unifying a  
41  
42 generic functional structure (GFS) and a corresponding generic technology structure (GTS).  
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47 As with the decomposition of a product into assemblies and parts at different levels of the  
48  
49 product hierarchy, the function of a product can be decomposed into subfunctions and elementary  
50  
51 functions. (The function of a product is the function that customers expect a product to perform.  
52  
53 Take a bicycle as an example, its product function is to transport a cyclist from one location to  
54  
55 another location.) While subfunctions are formed by child functions, be they subfunctions or  
56  
57 elementary functions, the elementary functions cannot be decomposed further. The implication is  
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59 that the realization of subfunctions depends on the realization of the child functions, whilst the  
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4 realization of an elementary function is directly achieved by the corresponding technologies. In this  
5  
6 regard, the decomposition entails an iterative process, stopping when all subfunctions have been  
7  
8 decomposed into elementary functions. Thus, the GFS includes all product functions, subfunctions,  
9  
10 elementary functions and their relationships that are necessary to deliver a product family<sup>1</sup>. Also  
11  
12 included are the properties describing functions and the possible values that these properties can  
13  
14 assume.  
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19  
20 Similarly, the GTS captures all the possible technologies to deliver the functions in the GFS. In  
21  
22 accordance with the product functions, subfunctions and elementary functions in the hierarchy of  
23  
24 the GFS, the GTS organizes the system technologies and child technologies at different levels of  
25  
26 abstraction. While a system technology is a composite one including child composite technologies  
27  
28 and/or child basic technologies, a basic technology is an atomic unit having no child. Thus, a basic  
29  
30 technology is directly implemented by components in the physical domain, a system technology is  
31  
32 implemented by the composite implementation of its child technologies. Each technology is  
33  
34 described by a number of attributes (e.g., air pressure and temperature as the attributes of a wafer  
35  
36 handling technology) and the possible values that these attributes can assume. Moreover, the  
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38 materials and/or tools that are necessary to implement the technologies are also specified.  
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47 Unifying the GFS modeling the functional domain and the GTS modeling the technology  
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49 domain forms the common FT structure. Therefore, the common FT structure captures not only the  
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51 data/information in each individual domain but also the interconnections (or mapping relationships)  
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53 between the two domains. The mapping relationships can be classified into several categories. One  
54  
55 basic category models the positive connections between functions and technologies, that is, the  
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<sup>1</sup> Note that a product can be decomposed in modules, and consequently, each product and/or module has its own functional tree. This paper focuses on the configuration mechanism behind the FT platform; therefore, for illustrative simplicity we do not discuss the relationships among functional trees.

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4 presence of one function calls for the presence of certain technologies. In contrast, the other basic  
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6 category reveals the negative connections between functions and technologies (i.e., the specification  
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8 of one function rules out the adoption of some technologies). The decision on using a certain  
9  
10 technology is affected by, e.g., the functional property values, the technology attributes. In this  
11  
12 regard, the common FT structure provides the positive connection between general functions (or  
13  
14 function types) and general technologies (or technology types), whilst it reflects the relationships,  
15  
16 be it positive or negative, among functional properties, property values, technology attributes and  
17  
18 attribute values. In summary, an FT platform contains all data describing functions, technologies  
19  
20 and the mapping relationships that is necessary for companies to design a product family in the  
21  
22 functional and technology domains. With the presence of similarity, the same types of data and  
23  
24 relationships are organized into a number of classes, such as functional element classes, technology  
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26 element classes and relationship classes. In addition, the relationships can be classified into three  
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28 types: class-to-class, class-to-member, member-to-member.  
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39 *Technology variant derivation.* For given functional specifications pertaining to a product, the  
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41 technologies and technology details, such as technology attributes and attribute values, can be  
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43 derived from the common FT structure. Such derivation is accomplished using a number of  
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45 selection and design rules. These rules can be constructed by considering the mapping relationships  
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47 between the GFS and the GTS at both the higher abstract level and the lower detailed level.  
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## 52 **2.2 Identification of the representation tool**

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55 In the literature, many representation/modeling languages or tools have been reported to  
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57 accommodate representation/modeling in both a generic context and a specific problem domain. In  
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59 this study, we focus on the analysis of an FT platform from the structural aspect, more specifically,  
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the representation of the constituent elements and relationships. Three commonly adopted structure

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4 representation tools include the UML (<http://www.uml.org/>), programming modeling languages  
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6 involving predicates and algebraic relations (e.g., [Neville and Joskowicz, 1993](#); [Joskowicz and](#)  
7  
8 [Neville, 1996](#)) and graph grammars (e.g., [Finger and Rinderle, 1989](#); [Hoover and Rinderle, 1989](#)).  
9  
10  
11 As noted by [Vernadat \(1993\)](#) and [Sutton et al. \(1990\)](#), programming modeling languages have  
12  
13 strong limitations in readability and understandability since they demand expertise in computer  
14  
15 systems. Graph grammars focus more on individual components rather than the system as a whole.  
16  
17 Due to the above inherent limitations, both representation languages cannot handle diverse types,  
18  
19 large volumes of data, which is fundamental to an FT platform. Moreover, the complex  
20  
21 relationships among the many data classes and instances in an FT platform make these last two  
22  
23 representation tools inefficient. To clearly represent an FT platform from the structural aspect, the  
24  
25 tool should possess the ability to not only explicitly capture the multiple data classes and their  
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27 specific member instances in terms of the data structures and characteristics but also sufficiently  
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29 model the many relationships among these classes and instances at different levels of abstraction.  
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39 Researchers, such as [Larsen et al. \(2001\)](#) and [Yang et al. \(2008\)](#), have recognized the necessity  
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41 of representing various components and their complicated relationships using the object-oriented  
42  
43 (OO) technology. Developed based on the OO technology, the UML has been recognized as a  
44  
45 promising tool to model complex systems, be they software or non software ([Rumbaugh et al., 1991](#);  
46  
47 [Booch, 1994](#)). It has thirteen diagrams, including class diagram, object diagram, activity diagram,  
48  
49 use case diagram, sequence diagram, etc. that are tailored to specify a system from different  
50  
51 perspectives. The class diagram is to model a system from the structural aspect. In addition, a  
52  
53 standardized extension mechanism is defined, in attempting to adapt this general modeling language  
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55 to specific application domains. While the UML class diagram can accurately represent classes and  
56  
57 their relationships, the extension mechanism is able to model member instances and relationships  
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4 • *Function cluster* - An entity of the type *functional cluster* represents a function variant at  
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6 any arbitrary intermediate level of the GFS. It comprises a group of functions, be they child  
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8 function clusters or elementary functions. The constitute elements of a function cluster are logically  
9  
10 connected with respect to, e.g., overlap, synergy, interfaces. Together with sibling elementary  
11  
12 functions and/or function clusters, they contribute to parent function clusters at a higher level or the  
13  
14 product function at the top level.  
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20 • *Elementary function* - An entity of the type *elementary function* represents an  
21  
22 indecomposable basic function at the lowest level of the GFS. In general, elementary functions are  
23  
24 specified based on, e.g., the functions of existing products, the new customer requirements, the  
25  
26 designers' expertise.  
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30  
31 • *Property* - An entity of the type *property* describes a characteristic of an entity of the type  
32  
33 *function*. It, thus, defines a performance indicator of the product/component in consideration. An  
34  
35 example of function property is Accuracy, which defines the precision need of the function: Position  
36  
37 wafer. In most cases, one function has multiple properties. A property specifies a range of values  
38  
39 from which one value has to be chosen in creating a function variant.  
40  
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44 • *Value* - An entity of the type *value* is an assignment of an entity of the type *property*. A  
45  
46 number of possible values can be assigned to a property. A specific function (i.e., a function variant)  
47  
48 has a value for each of its properties. In other words, after all specific values of the corresponding  
49  
50 properties of a generic function are determined, a function variant is obtained.  
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54  
55 • *Property value* - An entity of the type *property value* defines a relationship between a  
56  
57 property and a value. It is the combination of an entity of the type *property* and an entity of the type  
58  
59 *value*. A set of specific property value pairs defines a unique function (i.e., a function variant).  
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4 incompatible with  $P_j V_{jj}^*$  (the  $j$ -th value of the  $j$ -th property of the function). In the second situation,  
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6  
7 a link connects two instances of the same class. Such a link can only be *XOR* since the instances are  
8  
9 options of a generic function (e.g., the link between  $FC_{ii}^*$  and  $FC_{ij}^*$  in Figure 4(b), between  $F_j^*$  and  
10  
11  $F_m^*$  in Figure 4(c)). It means at one time, only one instance can be chosen to represent the class. In  
12  
13 the third situation, a link exists between instances of *function* and *property*, *value*, *property value*, as  
14  
15 shown in Figure 4(c). Such link has a keyword *has*. It indicates a function has properties and  
16  
17 property values.  
18  
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22  
23 • *Dependency*. A dependency indicates a semantic relationship between two classes. The  
24  
25 dependency between *property* and *value* means properties must be bound to actual values in order  
26  
27 to express certain meaning. After the binding, a new class *property value* is created.  
28  
29

30  
31 • *Shared aggregation*. A shared aggregation is a special kind of aggregation. It represents the  
32  
33 relationship between a part and a whole, where the part can be a part in a number of wholes. The  
34  
35 shared aggregation between *product function* and *elementary function*, *function cluster* and  
36  
37 *elementary function* indicates that a number of product functions and function clusters can share a  
38  
39 set of common elementary functions. Figure 4(b) shows the shared aggregation between product  
40  
41 function and function cluster. Note, each product or module can have its functional three on its own  
42  
43 aggregation level.  
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49 • *Generalization*. A generalization is the taxonomic relationship between a more general class  
50  
51 (the super-class) and a more specific class (the subclass). Such a subclass is fully consistent with the  
52  
53 super-class while adding additional information. The connection between *product function* and  
54  
55 *function* indicates a generalization connection (see Figure 4(b)).  
56  
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### 60 4.3 Selection rules

The construction of the GFS depends on a set of selection rules. Representing design knowledge,

selection rules specify the circumstance under which a function is a constituent of another function or a particular function variant can be specified. They are defined to present the designers with feasible functional options. The general form of selection rules is as follows:

(consequent) IF (antecedent),

where the relationship OR ( $\vee$ ) and AND ( $\wedge$ ) can be applied to both antecedent and consequent. For example, for  $P_iV_{ij}^*$ ,  $P_iV_{jj}^*$ , and  $P_iV_{ji}^*$ :

$$\{F_i | F_{ij}^*\} \wedge \{F_j | F_{ji}^*\} \text{ IF } \{P_jV | P_jV_{ji}^*\} \vee \{P_iV | P_iV_{ij}^*\} \wedge \{P_jV | P_jV_{jj}^*\} \quad (1)$$

$$\{P_jV | P_jV_{ji}^*\} \text{ IF } \{P_iV | P_iV_{ij}^*\} \quad (2)$$

In the above rules,  $F_x$  represents the x-th function class (or generic function);  $F_{xy}^*$  denotes the y-th variant of the x-th generic function;  $P_xV$  is the set of value instances of the x-th property; and  $P_xV_{xy}^*$  is the y-th value instance of the x-th property. Rule (1) indicates that when  $P_jV_{ji}^*$  or both  $P_iV_{ij}^*$  and  $P_jV_{jj}^*$  are specified, two function variants  $F_{ij}^*$  and  $F_{ji}^*$  have to be selected together to form the parent function. Rule (2) means the necessary condition for selecting  $P_jV_{ji}^*$  is that  $P_iV_{ij}^*$  is specified.

Selection rules are defined taking into account a set of constraints related to, e.g., environment concerns, economic factors, customer requirements. These rules describe the compatibility of function variants and property values. Hence, in collaboration with functional elements and their relationships, selection rules can determine specific functions pertaining to customized products.

#### 4.4 UML-based representation of GFS

The GFS represented using the UML is given in Figure 5. As shown, a function can be a product function, a function cluster or an elementary function at an arbitrary level of the GFS. A product function may consist of elementary functions and function clusters. In turn, each function cluster may contain its own child function clusters and/or elementary functions.



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4 technology at the highest level of a GTS, a technology cluster at an intermediate arbitrary level, or a  
5  
6 basic technology at an elementary level. Examples of technologies are mechanical engineering,  
7  
8 software engineering, opto-electronics, hydrodynamics, robotics, etc.  
9

10  
11  
12 • *System technology* - An entity of the type *system technology* represents a technology variant  
13  
14 at the top level of the GTS. It consists of various lower level technologies that together deliver the  
15  
16 overall function of an end product.  
17

18  
19  
20 • *Technology cluster* - An entity of the type *technology cluster* represents a technology variant.  
21  
22 It embodies a group of technologies that is clustered based on competences, functionality and  
23  
24 physical considerations. Together with others, a technology cluster contributes to the technology  
25  
26 cluster at a higher level or the system technology at the top level.  
27

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30 • *Basic technology* – A basic technology is an elementary unit at the lowest level of a  
31  
32 technology hierarchy and, cannot be decomposed further. Basic technologies are associated with  
33  
34 elementary functions. The determination of basic technologies, that are compatible to one another,  
35  
36 is influenced by the attribute values in association with the corresponding function property values.  
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41 • *Attribute* – An entity of the type *attribute* defines a characteristic of a technology entity and,  
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43 can assume a number of values. Usually, a technology is characterized by multiple entities of the  
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45 type *attribute*. Typical attributes in mechanical engineering include surface roughness, heat  
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47 treatment and material needed.  
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52 • *Value* – A value entity represents an assignment of an attribute entity. The attributes together  
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54 with their corresponding values define diverse technology variants.  
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58 • *Expert* – An expert entity is normally an engineer responsible for developing and/or  
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60 applying technologies. Experts are clustered based on their capabilities and expertise in  
technologies and the corresponding function clusters as well.















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4 the semiconductor equipment manufacturing industries to reduce product development costs and  
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7 time and to improve capacity allocation/utilization. Such reuse eventually leads to the efficient  
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10 design of tangible elements (i.e., physical components) by supporting product development with  
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12 configuring design variants based on a FT platform. In addition, the study complements previous  
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15 studies by providing a clear definition of FT platforms. Viewed from the architectural perspective,  
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18 an FT platform is underpinned by a common FT structure; it enables the derivation of specific  
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21 technology details in accordance with the given functional details pertaining to a customized  
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24 product. The common FT structure is formed by unifying a GFS with a GTS, which organize the  
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27 data and knowledge in the functional and technology domains, respectively.

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30 It is important to recognize that there are limitations in this research. When market diversity can  
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33 be aggregated by defining physical product variants, it is better for the firm to apply physical  
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36 platforms in defining variants. As customer involvement in design and engineering increases, the  
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39 application of FT platforms becomes increasingly justified. When the level of customer  
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42 involvement in product design and engineering is high (by for example a lead customer), the  
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45 strategy can be based on FT platforms. As such, the components that could constitute a physical  
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48 platform are changed frequently. The FT platform approach is applicable in situations where  
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51 customer orders require additional engineering. Thus, the FT platform concept enables firms that  
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54 deliver products based on additional engineering to reuse design elements. The study is, however,  
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57 based on data of industrial machinery manufacturing, and therefore more case comparison with  
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60 other branches of industries is needed for further generalization. Future research therefore could  
extend this work to understand the impact of FT platforms in other industries. Furthermore, we  
based the representation in this study on one assumption: the mapping relationships between the  
GFS and the GTS are available. In practice, due to the complexity involved, it may not be easy to

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4 obtain these relationships; and in most cases, these relationships are implicitly embedded in the  
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6 large volumes of data existing in companies' databases. In this regard, future research may be  
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8 directed to identify the mapping relationships between the functional and technology domains using,  
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10 e.g., data/text mining techniques. While structural representation of an FT platform can present the  
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12 constituent elements and relationships from a static viewpoint, it is not able to shed light on the  
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14 dynamics of an FT platform, i.e., how the functions and technologies are reused, how the specific  
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16 technology details are derived. Thus, another avenue for future research might be the dynamic  
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18 modeling of an FT platform with respect to, e.g., reuse of functions and technologies, derivation of  
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20 technology details.  
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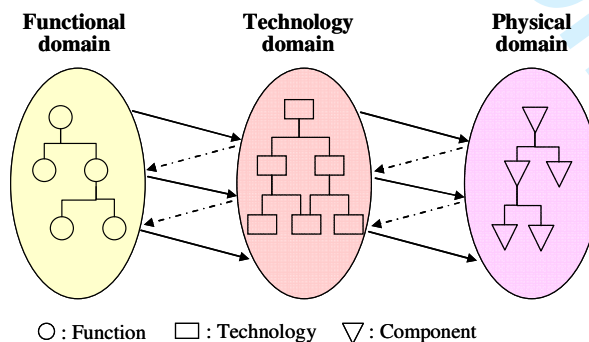


Figure 1. The three domains in product development (adapted from (Erens and Verhulst, 1997))



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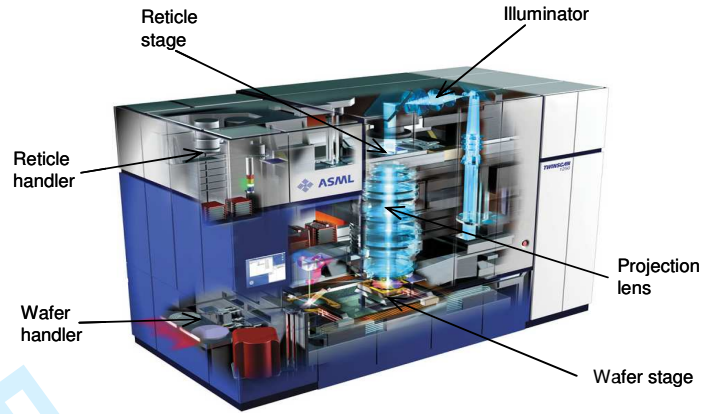


Figure 2. The major modules of a microlithography machine

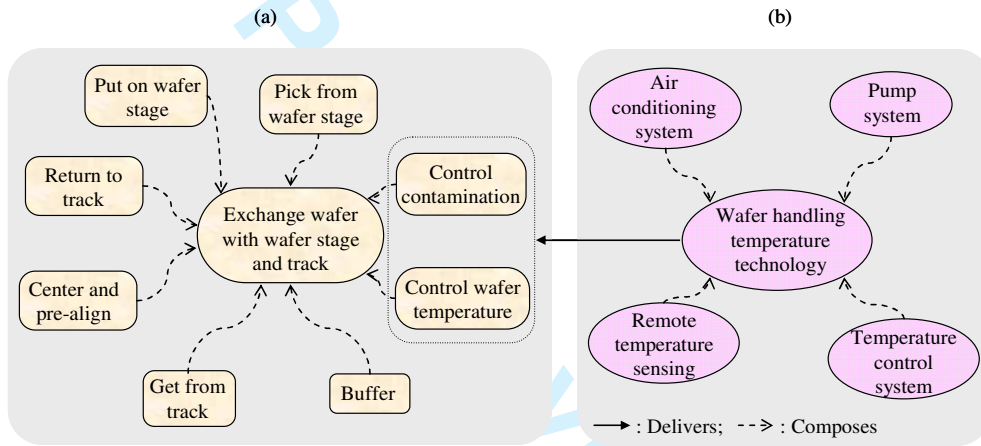
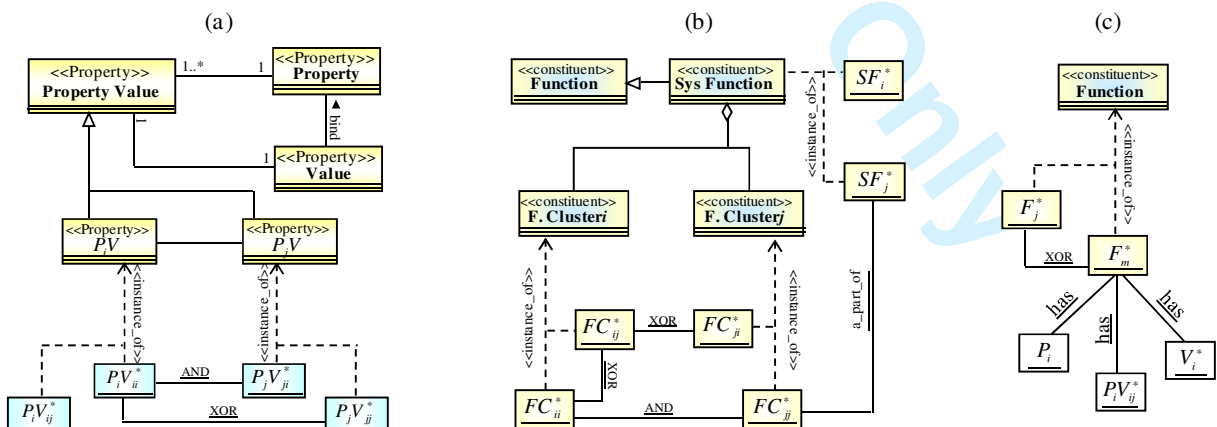
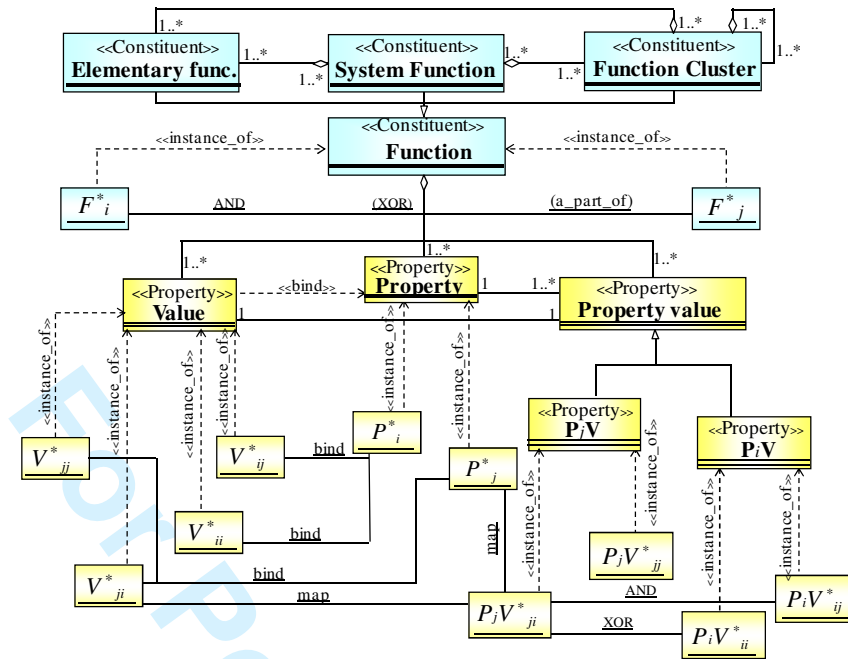


Figure 3. The functions and technologies associated with wafer handlers



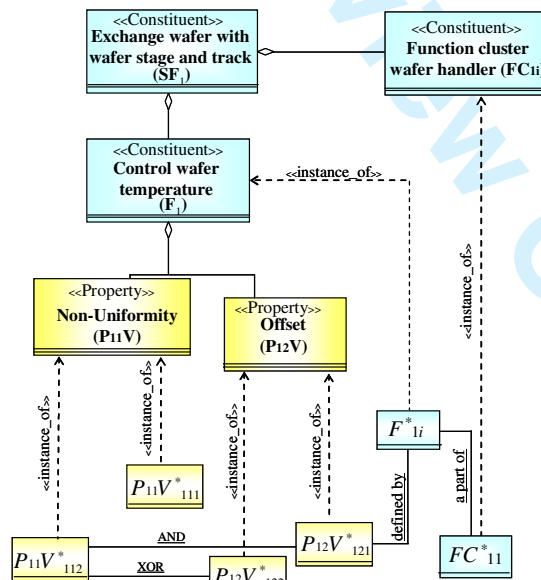
■: class □: instance <<instance\_of>>: instance of keyword: link —: association —>: generalization —◇: shared aggregation  
 $FC_{ij}^*$ : the  $y$ -th variant of the  $x$ -th functional cluster  $P_i V$ : the set of value instances of the  $x$ -th property  $V_x^*$ : the  $x$ -th value instance  
 $P_i V_{ij}^*$ : the  $y$ -th value instance of the  $x$ -th property  $F_x^*$ : the  $x$ -th function variant  $SF_x^*$ : the  $x$ -th system function variant  $P_x$ : the  $x$ -th property

Figure 4. Associations and links in a GFS



**Legend:** : class; : instance; : instance of; : association; : dependency; : link; : generalization; : shared aggregation;  $F_x^*$ : the x-th function variant;  $P_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th property;  $FC_x^*$ : the x-th function cluster

Figure 5. Representation of the generic functional structure



**Legend:** : class; : instance; : instance of; : association; : dependency; : link; : generalization; : shared aggregation;  $F_x^*$ : the x-th function variant;  $P_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th property;  $FC_x^*$ : the x-th function cluster  $SF_x$ : the x-th system function variant;

Figure 6. A partial GFS of the microlithography machine family

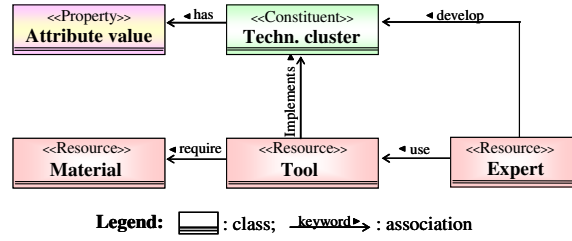
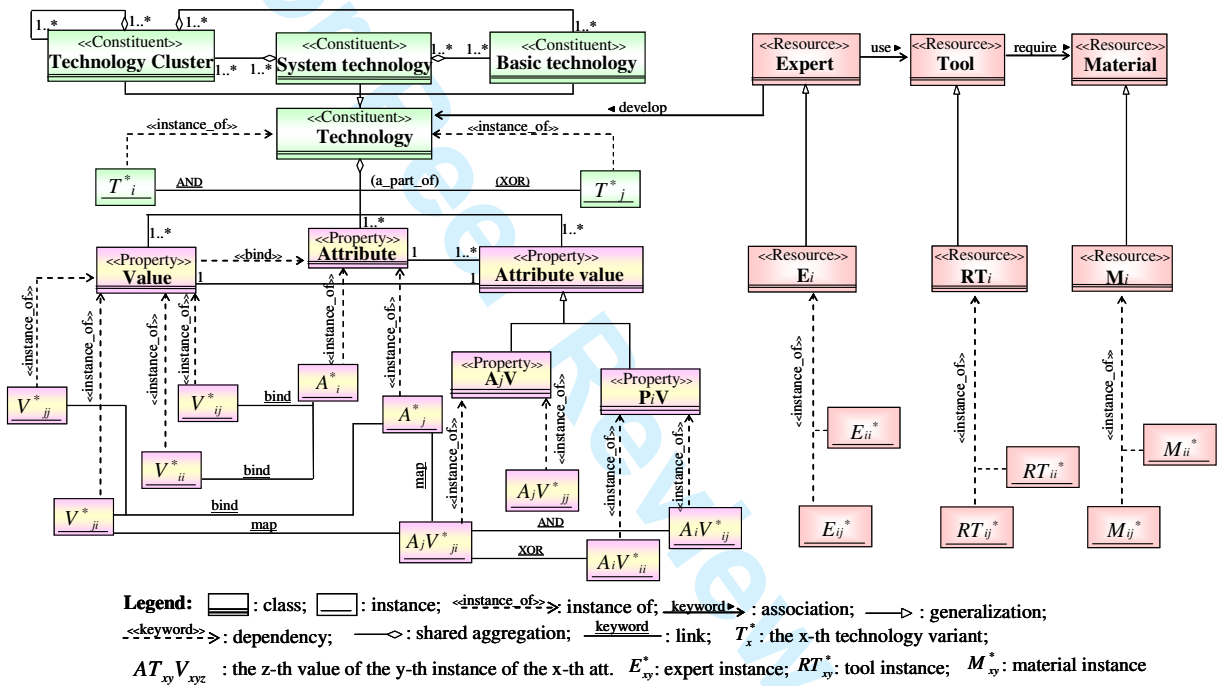
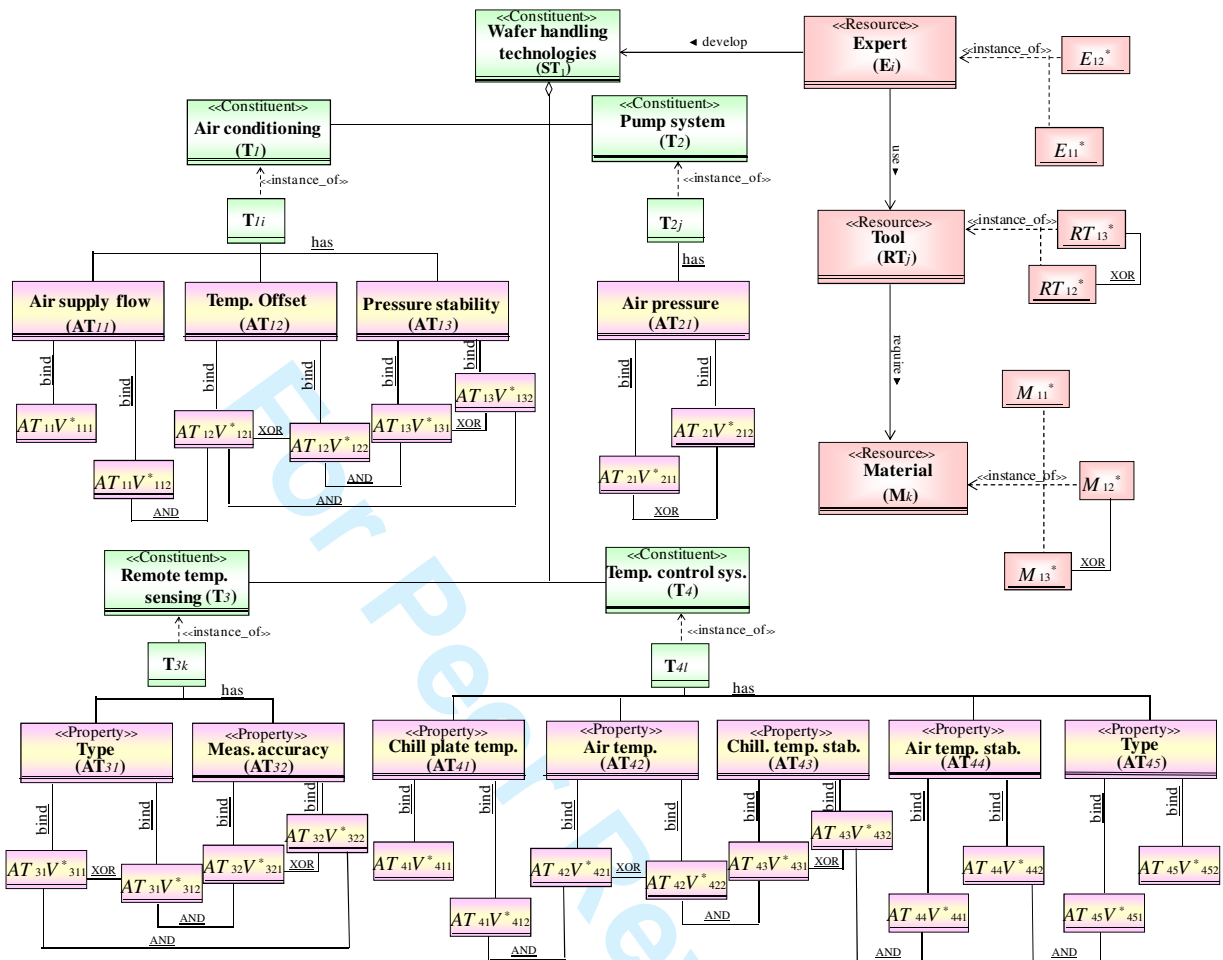


Figure 7. Association between technology elements



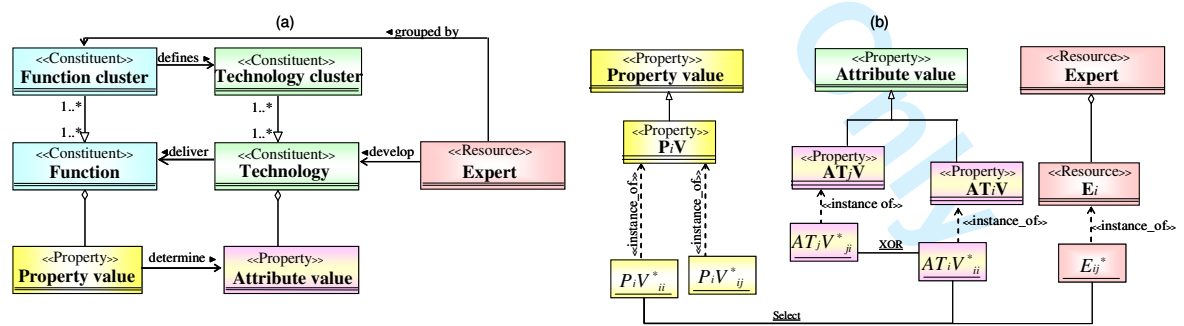
**Legend:**  : class;  : instance;  : instance of;  : association;  : generalization;  : dependency;  : shared aggregation;  : link;  $T_x^*$ : the x-th technology variant;  $AT_{xy} V_{xyz}$ : the z-th value of the y-th instance of the x-th att.  $E_{ij}^*$ : expert instance;  $RT_{ij}^*$ : tool instance;  $M_{ij}^*$ : material instance

Figure 8. Representation of the generic technology structure



Legend:  $\square$ : class;  $\square$ : instance;  $\dashrightarrow$ : instance of;  $\dashrightarrow$ : association;  $\dashrightarrow$ : generalization;  $\dashrightarrow$ : shared aggregation;  $\dashrightarrow$ : link;  $\dashrightarrow$ : dependency;  $T_x^*$ : the x-th basic technology variant;  $AT_{xy}V_{xyz}^*$ : the z-th value of the y-th instance of the x-th att.  $ST_x$ : the x-th system technology variant

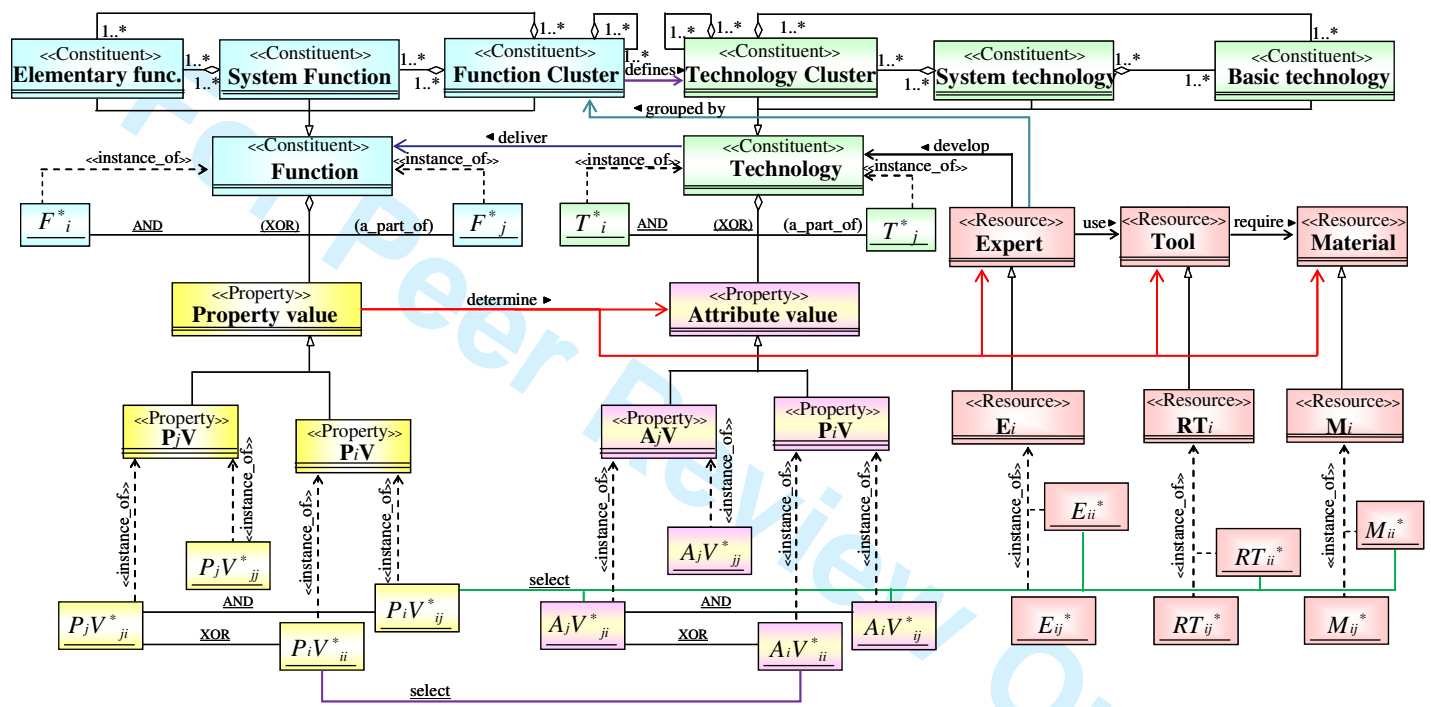
Figure 9. Partial representation of the GTS of the microlithography machine family



Legend:  $\square$ : class;  $\square$ : instance;  $\dashrightarrow$ : instance of;  $\dashrightarrow$ : association;  $\dashrightarrow$ : generalization;  $\dashrightarrow$ : link;  $E_{xy}^*$ : expert;  $\dashrightarrow$ : dependency;  $P_{xy}V_{xyz}^*$ : the z-th value of the y-th instance of the x-th property;  $AT_{xy}V_{xyz}^*$ : the z-th value of the y-th instance of the x-th att.

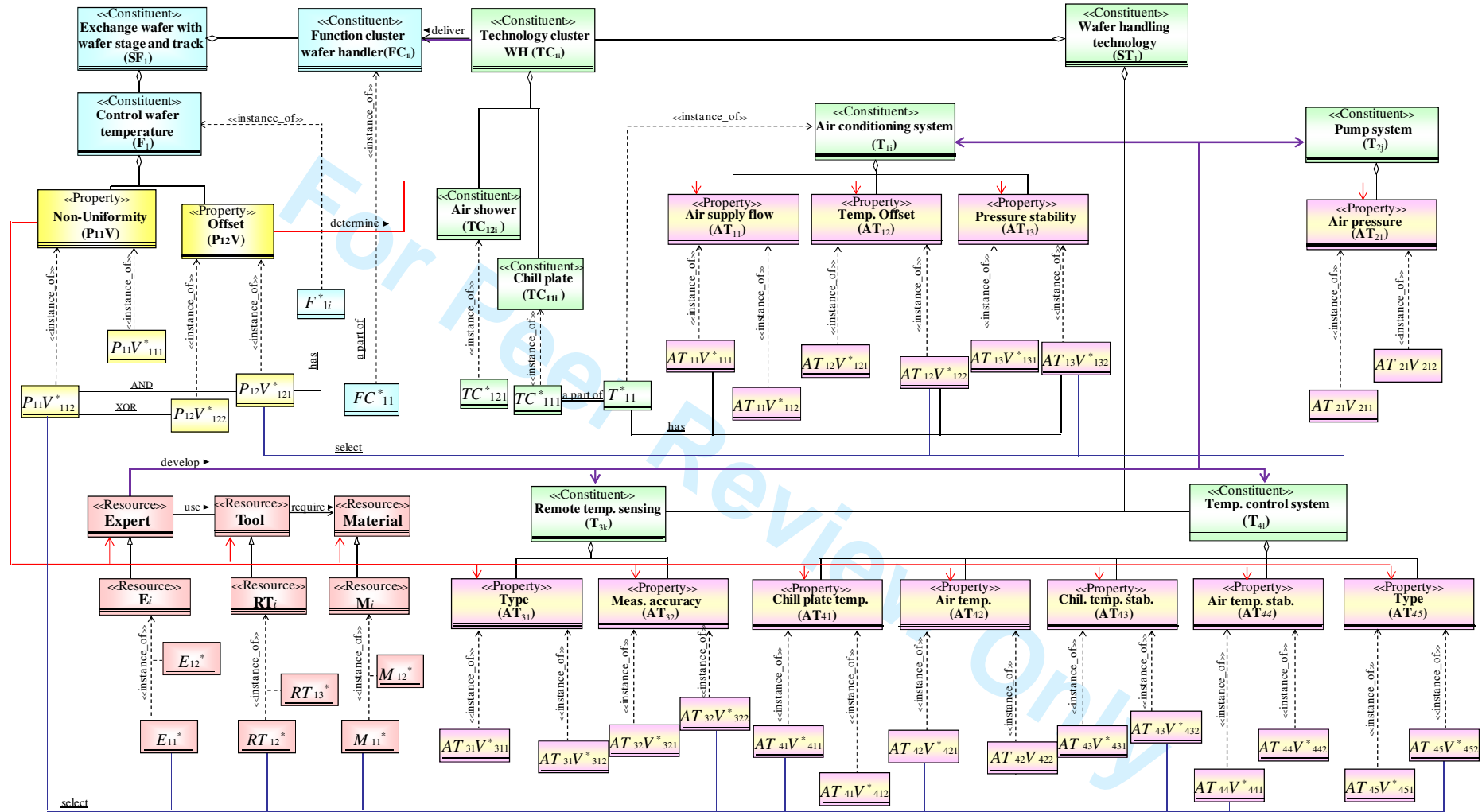
Figure 10. Associations and links between functional and technology elements

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**Legend:**   : class;   : instance;  $\langle\langle$ instance\_of $\rangle\rangle$  : instance of;  $\langle$ keyword $\rangle$  : association;  $\longrightarrow$  : generalization;  $\longleftarrow$  : shared aggregation;  $\langle$ keyword $\rangle$  : link;  $\langle\langle$ keyword $\rangle\rangle$  : dependency;  $F_x^*$ : the x-th function variant;  $T_x^*$ : the x-th technology variant;  $AT_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th attributes;  $P_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th property

Figure 11. Representation of entities and relationships in the FT platform



**Legend:**   : class;   : instance;   : instance of;   : association;   : generalization;   : shared aggregation;   : link;   : dependency;

$AT_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th att.  $P_{xy}V_{xyz}$ : the z-th value of the y-th instance of the x-th property;  $F_x^*$ : the x-th function variant;  $FC_x^*$ : the x-th function cluster variant;

$T_x^*$ : the x-th technology variant;  $TC_x^*$ : the x-th technology cluster;  $SF_x$ : the x-th system function variant;  $ST_x$ : the x-th system technology variant;  $E_x^*, RT_x^*, M_x^*$ : resp. the x-th expert, tool and material

Figure 12. The partial FT platform for the wafer handler family

## A LIST OF TABLES

Table 1. Properties associated with the function Control wafer temperature

Table 2. Technologies associated with the wafer handler function Control wafer temperature

Table 3. Functional and technology details for a customized wafer handler

Table 1. Properties associated with the function Control wafer temperature

Functions	Properties	Property descriptions	Possible values
Control wafer temperature	Maximum non-uniformity in the wafer.	The quality of being inconsistent uniformity among the temperature in the wafer.	20mK, 35mK
	Maximum offset of the air temperature inside the wafer stage compartment with respect to the wafer table.	The counterbalance of the temperature in the wafer stage compartment	20mK, 100mK
	Maximum offset of the air temperature inside the wafer stage compartment with respect to the lens cool water.	The counterbalance of the temperature in the wafer stage compartment	30mK, 110mK
<i>Note: The unit of measure for both properties is mK (millikelvin).</i>			

Table 2. Technologies associated with the wafer handler function Control wafer temperature

Technologies	Attributes	Unit of measure	Possible Values
Air conditioning system	Air supply flow	Cubic meter per hour (m <sup>3</sup> /hr)	≥ 400, (300, 400)
	Temperature offset with respect to (w.r.t.) lens cool water (LCW) or wafer table (WT)	Millikelvin (mK)	≤ 100 w.r.t LCW, ≤ 50 w.r.t LCW, ≤ 50w.r.t WT, ≤ 25 w.r.t WT
	Pressure stability	Millibar per second (mbar/s)	5, 10
Pump system	Air pressure within the wafer handler	Pascal (Pa)	≤ 2.75 x 10 <sup>2</sup> (Normal), ≤ 3.00 x 10 <sup>-1</sup> (Vacuum)
Remote temperature sensing	Type	Type	Normal, Vacuum
	Measurement accuracy	Millikelvin (mK)	0.1, 1
Temperature control system	Type	Type	Chill plate, Conditioned air flow
	Chill plate temperature	Celsius (C)	(22.5, 23.1), (21.5, 25.0)
	Air temperature	Celsius (C)	(21.5, 22.1), (20.5, 23.0)
	Chill plate temperature stability	Millikelvin per minute (mK/ min)	(12 mK/3min), (15 mK/5min)
	Air temperature stability	Millikelvin per minute (mK/ min)	(60 mK/3min), (70 mK/5min)

Table 3. Functional and technology details for a customized wafer handler

Function	Property	Values	Technology	Attributes	Values
Temperature control	Maximum non-uniformity in the wafer.	20 mK	Air conditioning	Air supply flow	$\geq 300 \text{ m}^3/\text{hr}$
				Temperature offset	(400, 200)mK w.r.t. LCW
				Pressure stability	5 mbar/s
			Temperature control	Chill plate temperature	(22.5, 23.1)
				Air temperature	(21.5, 22.1)
				Chill plate temperature stability	$\geq 2.4 \text{ mK/ min}$
				Air temperature stability	$\geq 12 \text{ mK/ min}$
	Type	Chill plate			
	Maximum offset of the air temperature inside the wafer stage compartment.	20 mK w.r.t. LCW	Pump system	Air pressure within the WH	$\geq 3.00 \times 10^{-1} \text{ Pa Vacuum}$
			Remote temperature sensing	Type	Vacuum
Measurement accuracy				$\geq 0.1 \text{ mK}$	